


<b>Search Notes</b>  	<b>Application/Control No.</b>  10524634	<b>Applicant(s)/Patent Under Reexamination</b>  FLOCKERZI ET AL.
	<b>Examiner</b>  Desai, Rita J	<b>Art Unit</b>  1625

SEARCHED			
Class	Subclass	Date	Examiner
546	101	11/6/07	RD
514	297	11/6/07	RD

SEARCH NOTES		
Search Notes	Date	Examiner
STN:- structure search, file registry, file caplus	11/6/07	RD
see west search.		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner